

APPLICANT'S ART CITATION (Use several sheets if necessary)			Application 09/914,081		OFGS File No. P/25-267	
			Applicant Donald Dominic ARNONE et al.			
			Filing Date April 23, 2002		Group Art Unit 2882	

U.S. PATENT DOCUMENTS						
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
PCH	US-5,789,750	08-1998	Nuss	250	338.1	RECEIVED JAN 28 2004 TECHNOLOGY CENTER R3700
PCH	US-5,623,145	04-1997	Nuss	250	330	
PCH	US-5,710,430	01-1998	Nuss	250	358.1	
	US-					
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FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
PCH	WO 97/45747	12-1997	PCT				
	EP 0 841 548 A2	05-1998	EPO				
	EP 0 828 162 A2	03-1998	EPO				

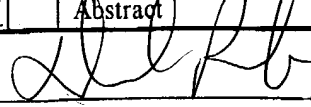
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)		
1.	Fattinger, et al., "Point Source Terahertz Optics" Appl. Phys. Lett. 53(16), 17 October 1988, pp. 1480-1482.	
2.	Fattinger et al., "Tetahertz Beams" Appl. Phys. Lett. 54 (6), 6 February 1989, pp. 490-492	
3.	Mittleman, et al. "T-Ray Imaging" IEEE Journal of Selected Topics in Quantum Electronics, 2 (3), September 1996, pp. 679-692.	
4.	Zamdmer et al., "On-Chip Frequency-Domain Submillimeter-Wave Transceiver" Appl. Phys. Lett. 75 (24), 12 December 1999, pp. 3877-3879.	

Examiner	Date Considered
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

<b>APPLICANT'S ART CITATION</b> (Use several sheets if necessary)		Application		OFGS File No. P/25-267 #8							
		Applicant Donald Dominic ARNONE et al.									
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U.S. PATENT DOCUMENTS											
Examiner Initial	Document Number				Date	Name	Class	Sub-class	Filing Date If Appropriate		
FOREIGN PATENT DOCUMENTS											
	Document Number				Date	Country	Class	Sub-class	Translation		
									Yes	No	
PLN	0	8	4	1	5	4	8	05/13/98	Europe		
I	0	8	2	8	1	4	3	03/11/98	Europe		
I	0	7	2	7	6	7	1	08/21/96	Europe		
	0	8	6	4	8	5	7	09/16/98	Europe		
PLN	2	2	5	4	4	1	7	10/07/92	Great Britain		
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PLN	WU Q ET AL: "TWO-DIMENSIONAL ELECTRO-OPTIC IMAGING OF THZ BEAMS"										
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	vol. 69, no. 8, 19 August 1996 (1996-08-19), pages 1026-1028, XP000626128										
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	vol. 13, no. 182 (C-591), 27 April 1989 (1989-04-27)										
	& JP 01 011530 A (HITACHI), 17 January 1989 (1989-01-17)										
PLN	Abstract										
Examiner					Date Considered		9-22-2004				
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